

Description:

This N+P Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge.

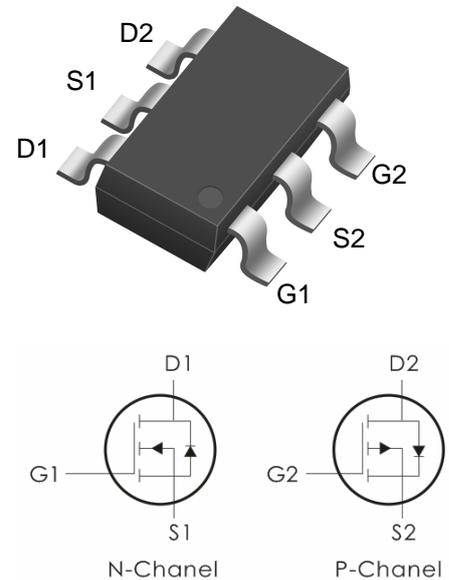
It can be used in a wide variety of applications.

Features:

N-Channel: $V_{DS}=40V, I_D=5.5A, R_{DS(on)} < 40m\Omega @ V_{GS}=10V$ (Typ: $28m\Omega$)

P-Channel: $V_{DS}=-40V, I_D=-4.5A, R_{DS(on)} < 75m\Omega @ V_{GS}=-10V$ (Typ: $62m\Omega$)

- 1) Low gate charge.
- 2) Green device available.
- 3) Advanced high cell density trench technology for ultra low $R_{DS(on)}$.
- 4) Excellent package for good heat dissipation.
- 5) MSL3



Package Marking and Ordering Information:

Part NO.	Marking	Package	Packing
DO4614S	4614S	SOT-23-6D	3000pcs/Reel

Absolute Maximum Ratings: ($T_A=25^\circ C$ unless otherwise noted)

Symbol	Parameter	N-Channel	P-Channel	Units
V_{DS}	Drain-Source Voltage	40	-40	V
V_{GS}	Gate-Source Voltage	± 20	± 20	V
I_D	Continuous Drain Current- $T_A=25^\circ C^1$	5.5	-4.5	A
	Continuous Drain Current- $T_A=100^\circ C^1$	3.8	-3.1	
I_{DM}	Pulsed Drain Current ²	22	-18	A
P_D	Power Dissipation - $T_A=25^\circ C$	2.3	2.3	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150		$^\circ C$

Thermal Characteristics:

Symbol	Parameter	N-CH	P-CH	Units
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	54.3	54.3	$^\circ C/W$

N-Channel Electrical Characteristics: ($T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu\text{A}$	40	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=40V$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	± 100	nA
On Characteristics						
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\ \mu\text{A}$	1	1.5	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance ³	$V_{GS}=10V, I_D=5A$	---	28	40	Ω
		$V_{GS}=4.5V, I_D=3A$	---	39	55	Ω
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=15V, V_{GS}=0V, f=1\text{MHz}$	---	490	---	pF
C_{oss}	Output Capacitance		---	65	---	
C_{rss}	Reverse Transfer Capacitance		---	40	---	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=20V, I_D=1A,$ $R_{ENG}=25\ \Omega, V_{GS}=4.5V$	---	3.2	---	ns
t_r	Rise Time		---	8.6	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	18	---	ns
t_f	Fall Time		---	6	---	ns
Q_g	Total Gate Charge	$V_{GS}=4.5V, V_{DS}=20V,$ $I_D=3A$	---	10	---	nC
Q_{gs}	Gate-Source Charge		---	0.5	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	1.5	---	nC
Drain-Source Diode Characteristics						
V_{SD}	Diode Forward Voltage	$V_{GS}=0V, I_{SD}=1A$	---	---	1	V
I_S	Continuous Drain Current	$V_D=V_G=0V$	---	---	5.5	A
I_{SM}	Pulsed Drain Current		---	---	22	A

Notes:

1. Computed continuous current assumes the condition of $T_{j,Max}$ while the actual continuous current depends on the thermal & electro-mechanical application board design
2. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$

N-Typical Characteristics: ($T_A=25^\circ C$ unless otherwise noted)

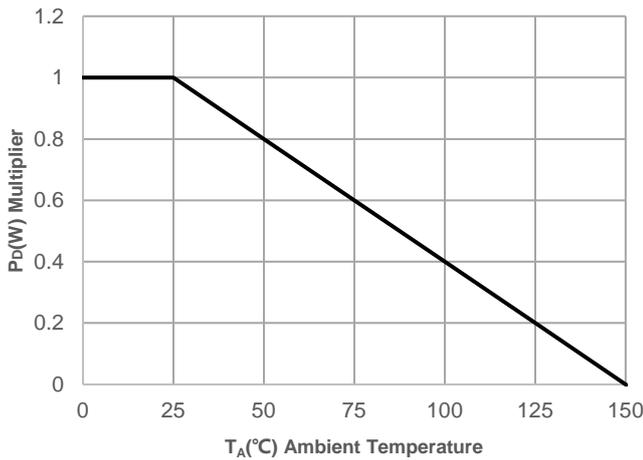


Figure 1: Power De-rating

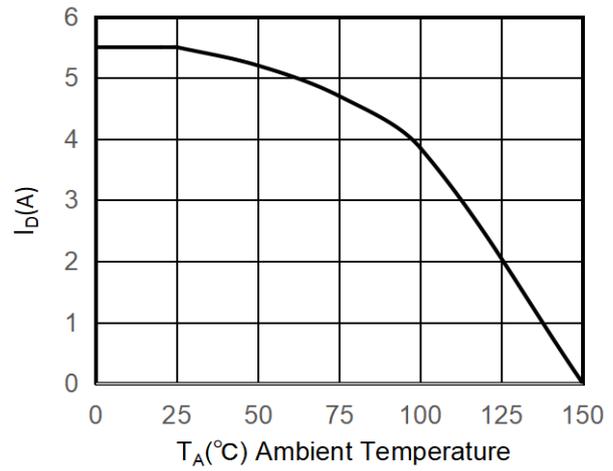


Figure 2: Current De-rating

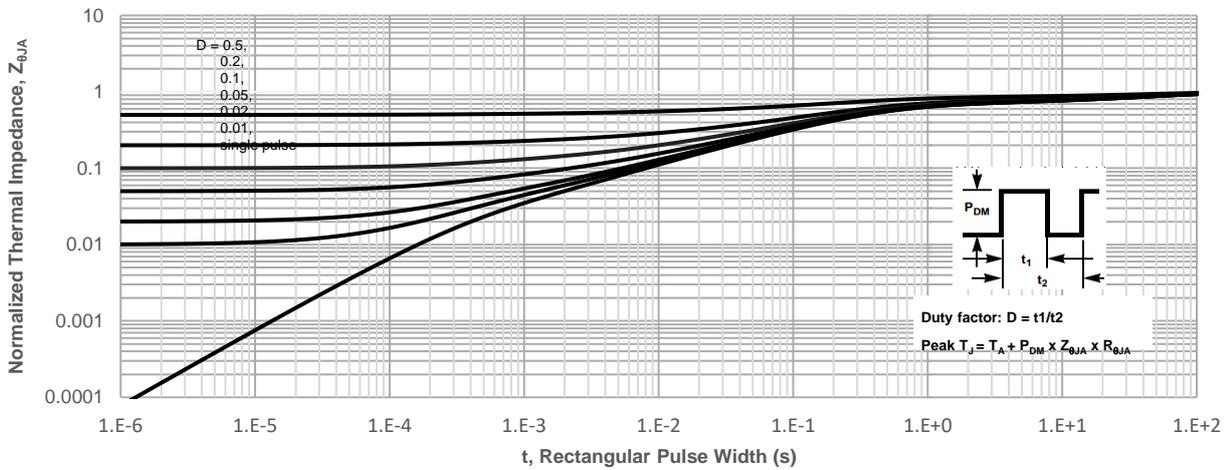


Figure 3: Normalized Maximum Transient Thermal Impedance



Figure 4: Peak Current Capacity

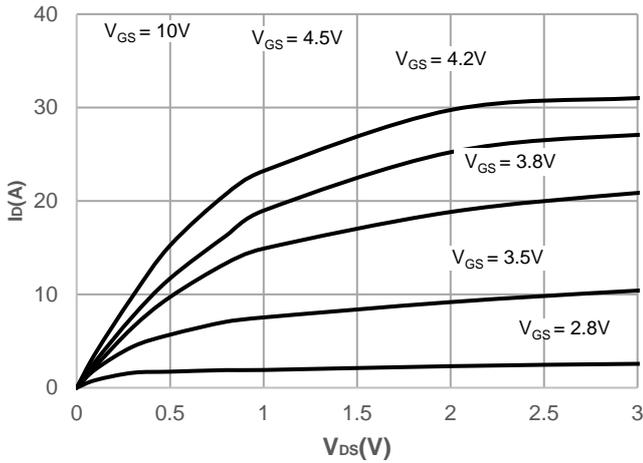


Figure 5: Output Characteristics

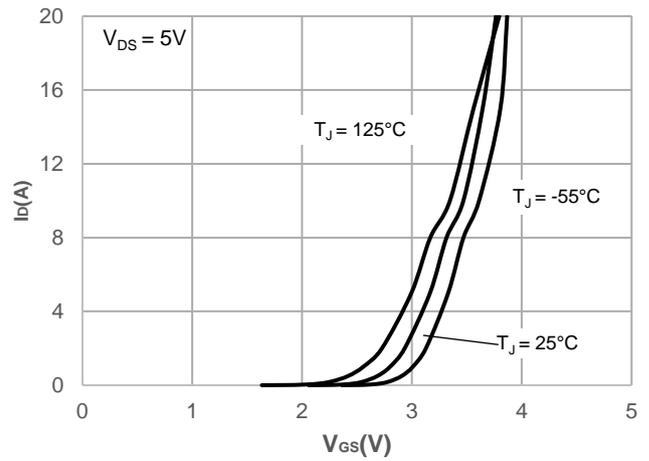


Figure 6: Typical Transfer Characteristics

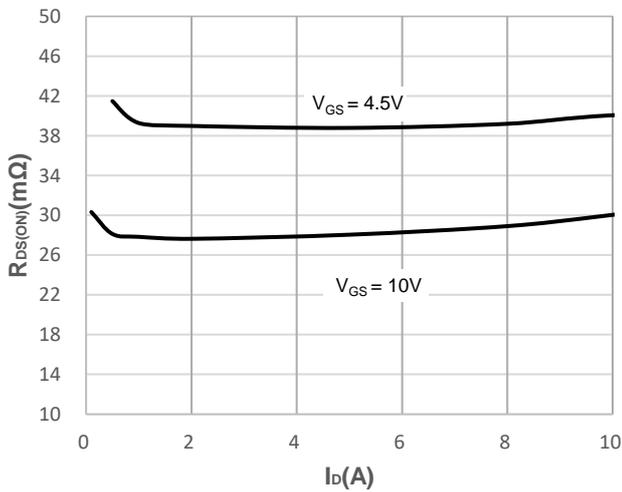


Figure 7: On-resistance vs. Drain Current

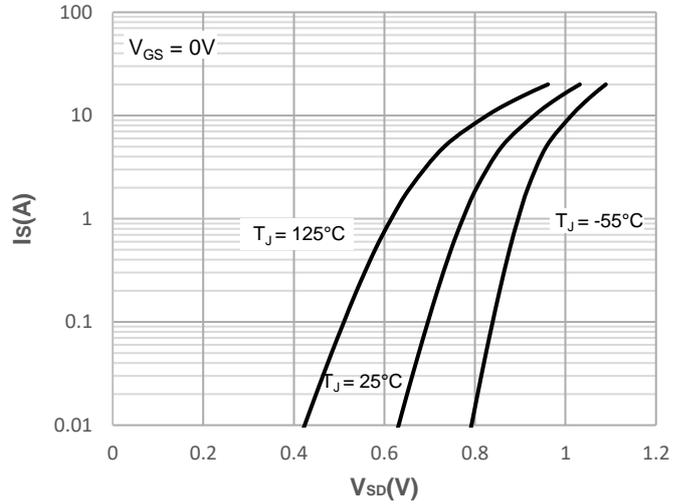


Figure 8: Body Diode Characteristics

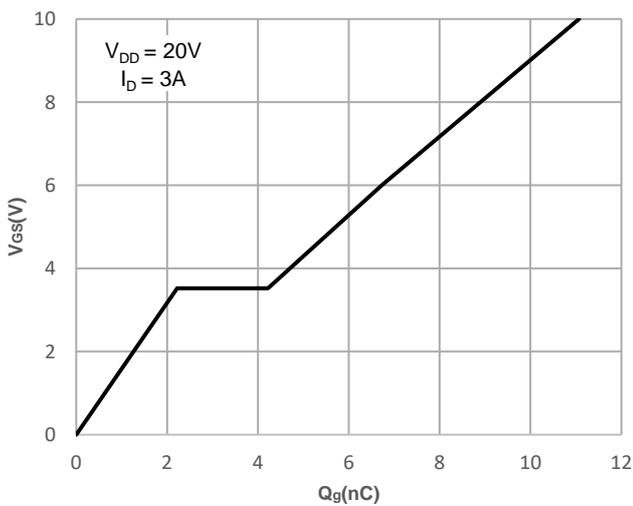


Figure 9: Gate Charge Characteristics

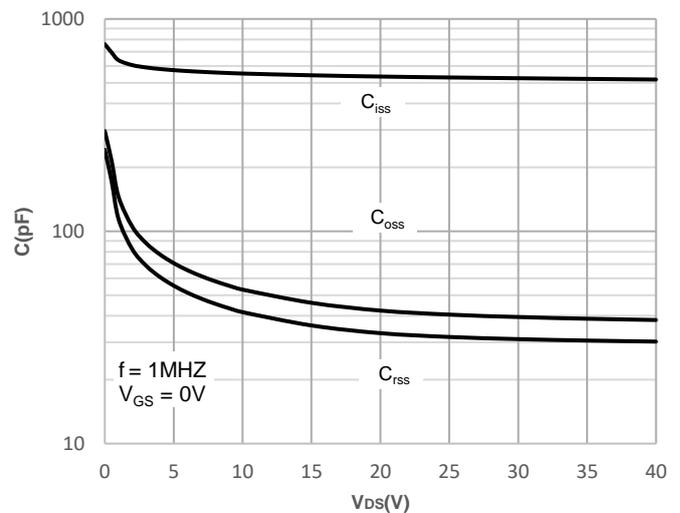


Figure 10: Capacitance Characteristics

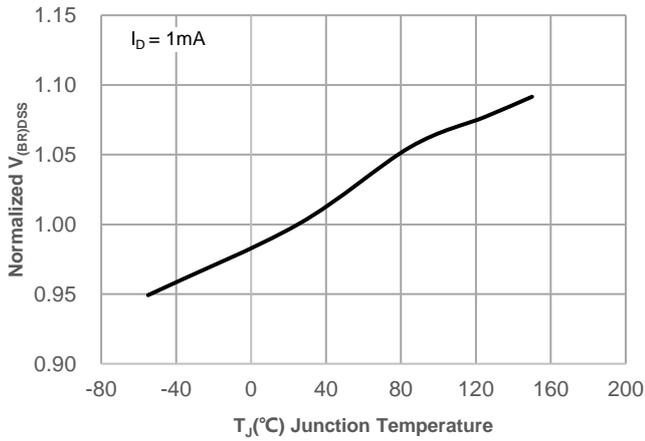


Figure 11: Normalized Breakdown voltage vs. Junction Temperature

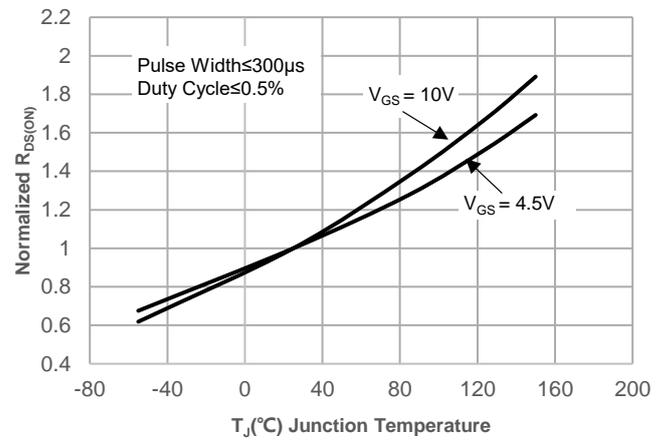


Figure 12: Normalized on Resistance vs. Junction Temperature

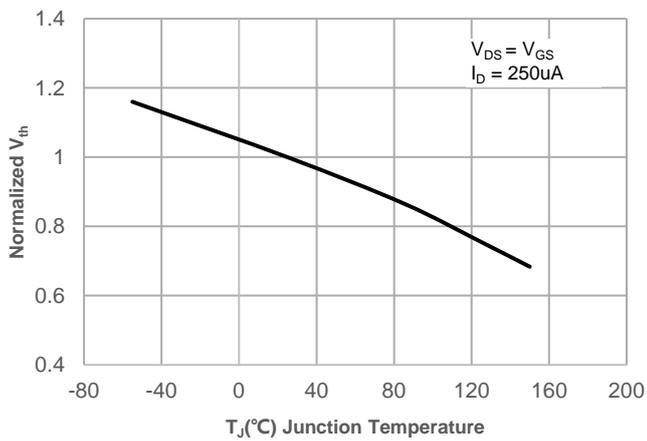


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

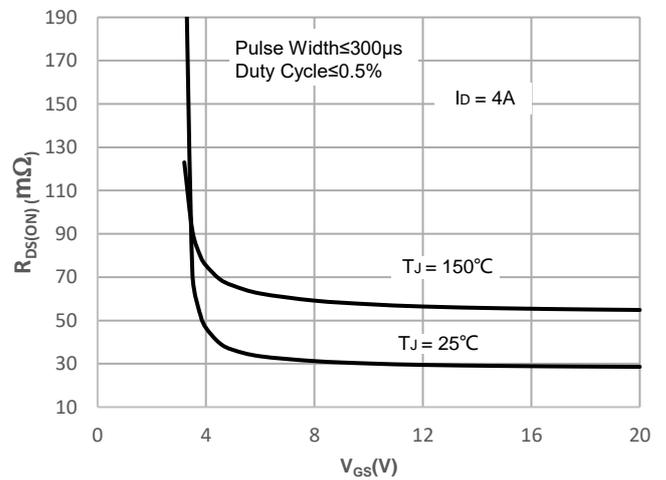


Figure 14: $R_{DS(ON)}$ vs. V_{GS}

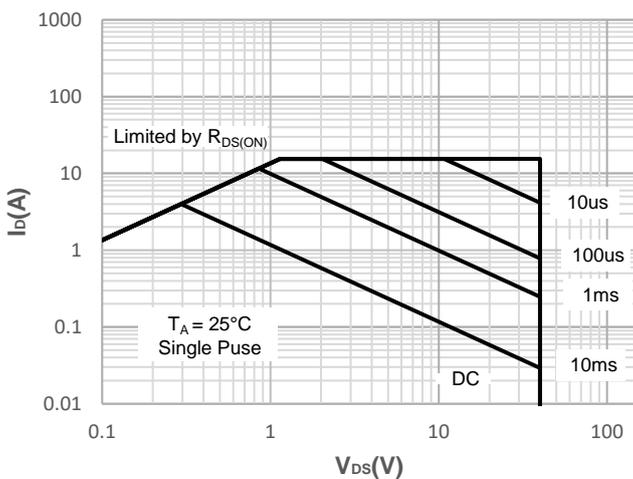


Figure 15: Maximum Safe Operating Area

P-Channel Electrical Characteristics: ($T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu\text{A}$	-40	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=-40V$	---	---	-1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	± 100	nA
On Characteristics						
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\ \mu\text{A}$	-1.2	-1.6	-2.5	V
$R_{DS(on)}$	Drain-Source On Resistance ³	$V_{GS}=-10V, I_D=-3A$	---	62	75	$\text{m}\Omega$
		$V_{GS}=-4.5V, I_D=-2A$	---	72	90	
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=20V, V_{GS}=0V, f=1\text{MHz}$	---	490	---	pF
C_{oss}	Output Capacitance		---	50	---	
C_{rss}	Reverse Transfer Capacitance		---	40	---	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD}=-20V, I_D=-5A$ $V_{GS}=-10V, R_{GEN}=2.5\ \Omega$	---	6.3	---	ns
t_r	Rise Time		---	13	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	33	---	ns
t_f	Fall Time		---	17	---	ns
Q_g	Total Gate Charge		---	11	---	nC
Q_{gs}	Gate-Source Charge	$V_{GS}=-10V, V_{DS}=-20V,$ $I_D=-3A$	---	1.3	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	1.7	---	nC
Drain-Source Diode Characteristics						
I_S	Continuous Drain to Source Diode	$V_D=V_G=0V$	---	---	-4.5	A
I_{SM}	Pulsed Drain to Source Diode		---	---	-18	---
T_{rr}	Reverse Recovery Time	$I_F=-5A, T_J=25^\circ\text{C}$	---	23	---	ns
Q_{rr}	Reverse Recovery Charge	$dI/dt=100A/\mu\text{s}$	---	25.2	---	nC
V_{SD}	Source-Drain Diode Forward Voltage	$V_{GS}=0V, I_S=-5A$	---	---	-1.2	V

Notes:

1. Computed continuous current assumes the condition of $T_{j,Max}$ while the actual continuous current depends on the thermal & electro-mechanical application board design
2. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$

P-Typical Characteristics: ($T_A=25^\circ C$ unless otherwise noted)

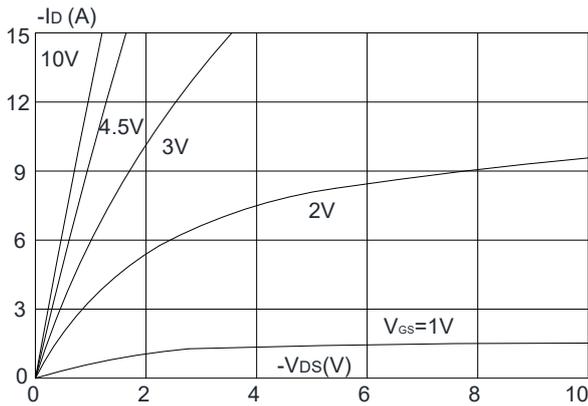


Figure 1: Output Characteristics

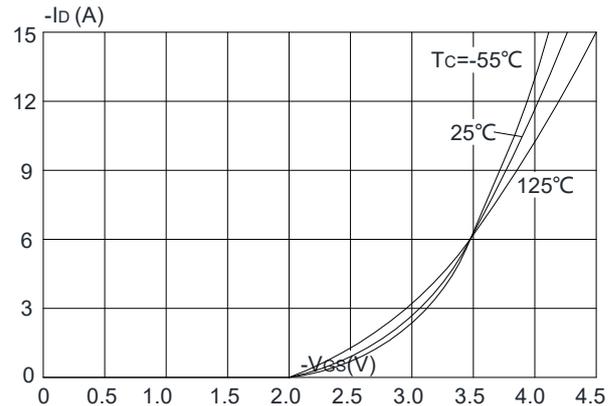


Figure 2: Typical Transfer Characteristics

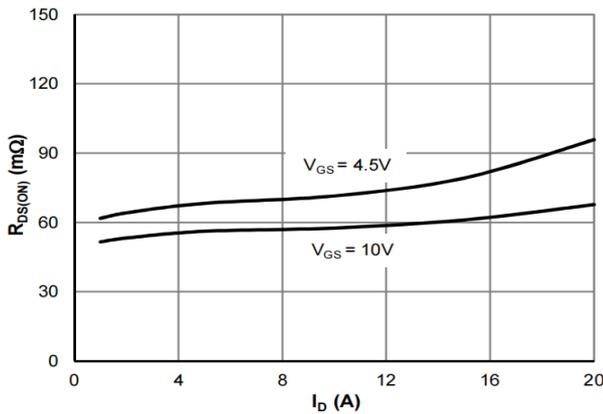


Figure 3: On-resistance vs. Drain Current

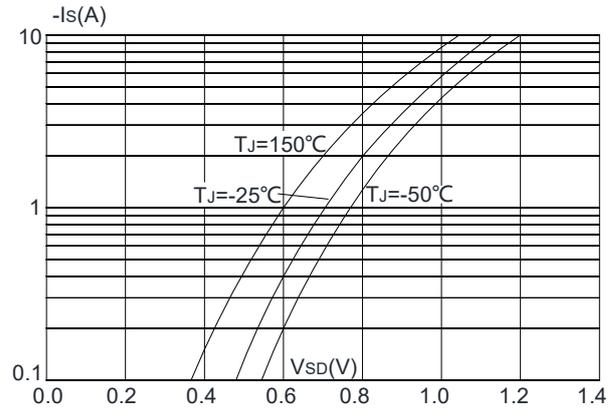


Figure 4: Body Diode Characteristics

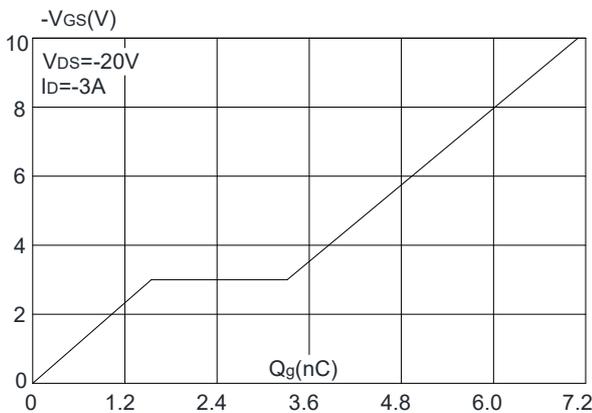


Figure 5: Gate Charge Characteristics

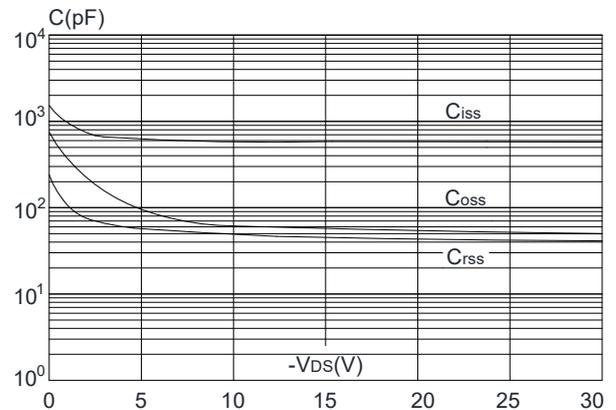


Figure 6: Capacitance Characteristics

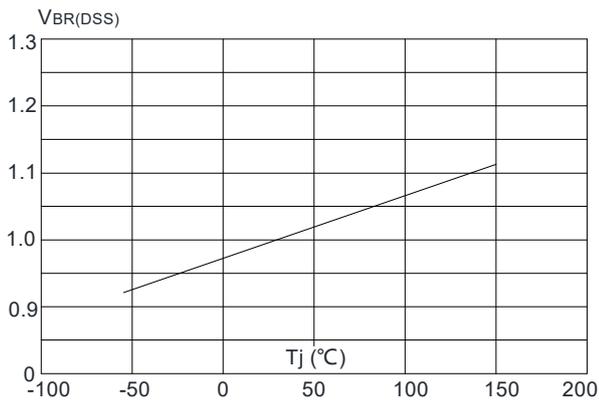


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

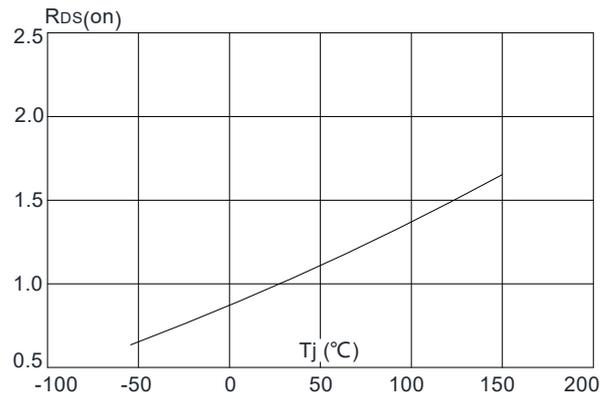


Figure 8: Normalized on Resistance vs. Junction Temperature

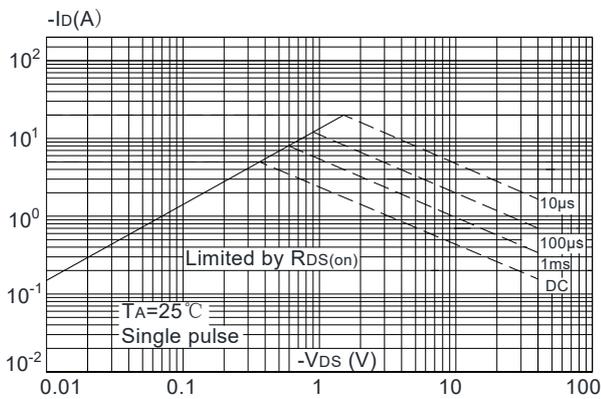


Figure 9: Maximum Safe Operating Area

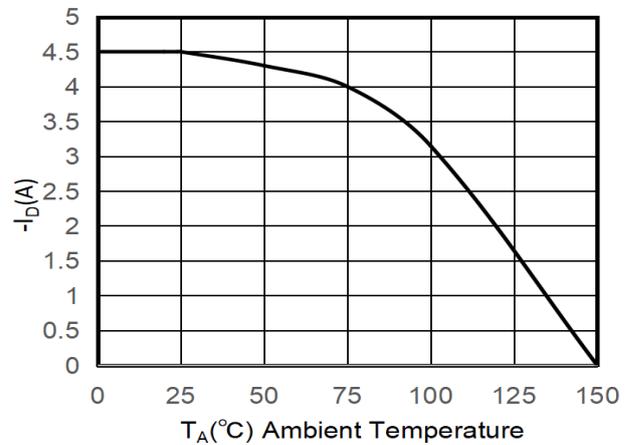


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

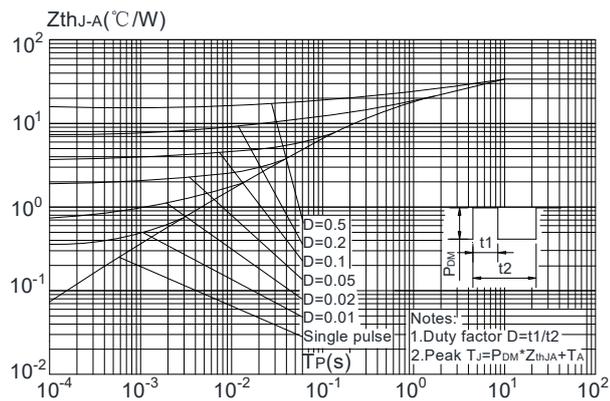
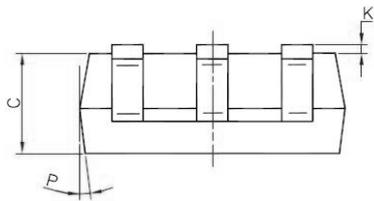
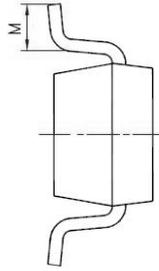
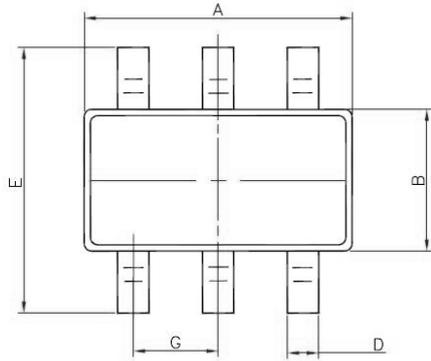


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

SOT-23-6 Package Outline Data

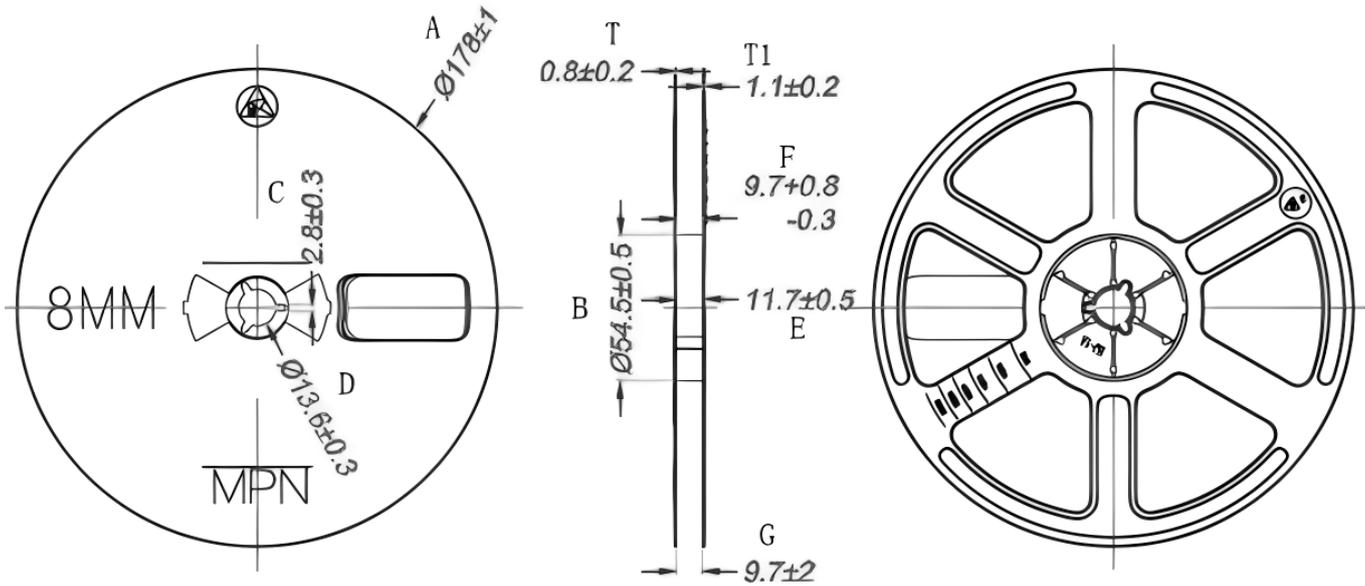


DIM	MILLIMETERS
A	2.82~3.02
B	1.60 ± 0.10
C	1.10 ± 0.05
D	0.40 ± 0.10
E	2.65~2.95
G	0.95typ
K	0.00~0.10
M	0.20MIN
P	9 ± 2°

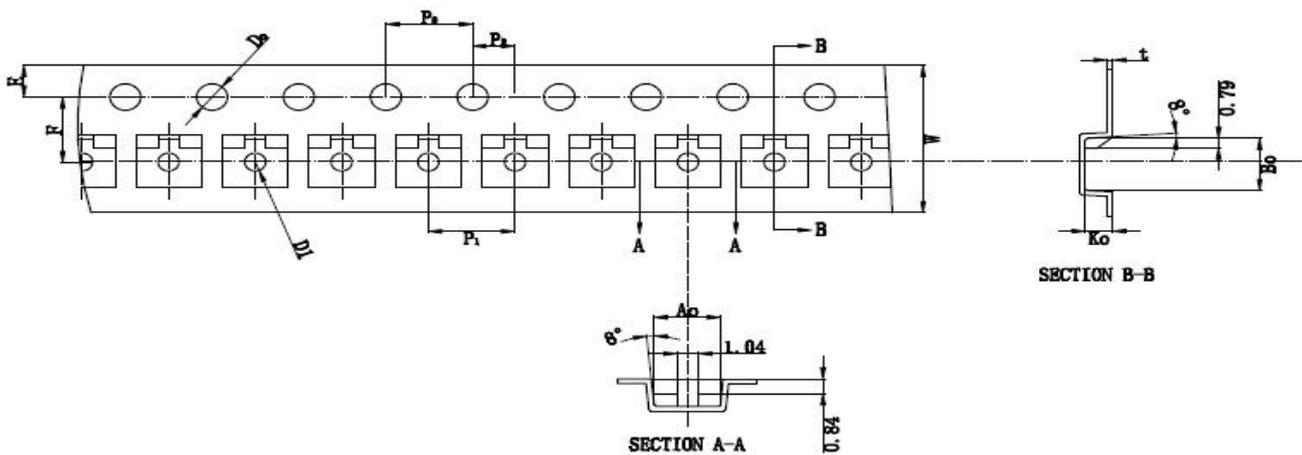
UNIT: mm

Tape & Reel Information

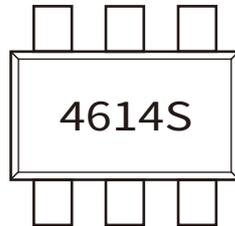
Dimensions in mm



PKG TYPE	W	P	E	F	D	D1	Po	Po10	P2	A0	B0	K0	T
SOT23-6	8.00	4.00	1.75	3.50	1.50	1.00	4.00	40.00	2.00	3.13	3.22	1.30	0.20
Tolerance	±0.2	±0.1	±0.1	±0.1	±0.1	±0.1	±0.1	±0.2	±0.1	±0.1	±0.1	±0.1	±0.03



Pulling direction →

Marking Information:**Previous Version**

Version	Date	Subjects (major changes since last revision)
1.1	2025-06-10	Release of final version

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